



Product data sheet

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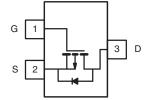




Features

- -30V,-0.2A, RDS(ON) =4.0Ω@VGS = -10V
- Improved dv/dt capability
- Fast switching
- Green Device Available

SOT-23



Applications

- Notebook
- Load Switch
- Battery Protection
- Hand-held Instruments

BVDSS	RDSON	ID
-30V	4.0Ω	-0.2A

Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	-30	V
Vgs	Gate-Source Voltage	±20	V
1	Drain Current – Continuous (T _A =25°C)	-0.2	A
ID	Drain Current – Continuous (T _A =70°C)	-0.1	A
Ідм	Drain Current – Pulsed ¹	-0.8	A
D	Power Dissipation (T _A =25°C)	1.0	W
Power Dissipation – Derate above 25℃		12.5	mW/°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
R _{0JA}	Thermal Resistance Junction to ambient		80	°C/W



Electrical Characteristics (TJ=25 °C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage V _{GS} =0V , I _D =-250uA		-30			V
1	Drain Source Lookage Current	V _{DS} =-30V , V _{GS} =0V , T _J =25℃			-1	uA
IDSS	Drain-Source Leakage Current	V _{DS} =-25V , V _{GS} =0V , TJ=125℃			-10	uA
I _{GSS}	Gate-Source Leakage Current	$V_{GS} = \pm 20V$, $V_{DS} = 0V$			±20	uA

On Characteristics

RDS(ON) Static Drain-Source On-Resistance		V _{GS} =-10V , I _D =-0.2A		4.0	8.0	Ω
Rds(on)		V _{GS} =-4.5V , I _D =-0.1A		8.0	10	52
V _{GS(th)}	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_{D}=-250$ uA	-1.0	-1.6	- 2.5	V
gfs	Forward Transconductance	V _{DS} =-10V , I _D =-0.2A		0.4		S

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{2,3}			2.8	
Q _{gs}	Gate-Source Charge ^{2,3}	V _{DS} =-30V , V _{GS} =-10V , I _D =-0.2A		0.96	 nC
Q_gd	Gate-Drain Charge ^{2,3}			0.6	
T _{d(on)}	Turn-On Delay Time ^{2,3}			3	
Tr	Rise Time ^{2, 3} V_{DD} =-30V , V _{GS} =-10V , R _G =6 Ω			5	 n 0
T _{d(off)}	Turn-Off Delay Time ^{2,3}	I _D =-0.2A		14	 ns
Tf	Fall Time ^{2,3}			9	
Ciss	Input Capacitance			30.5	
Coss	Output Capacitance	V _{DS} =-30V , V _{GS} =0V , F=1MHz		15.1	 pF
C _{rss}	Reverse Transfer Capacitance			7	

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter Conditions		Min.	Тур.	Max.	Unit
ls	Continuous Source Current				-0.2	А
Іѕм	Pulsed Source Current	V _G =V _D =0V , Force Current			-0.4	Α
Vsd	Diode Forward Voltage	V _{GS} =0V , I _S =-0.2A , T _J =25℃			-1.3	V
Trr	Reverse Recovery Time VR=-30V, IS=-0.2A			13.5		nS
Qrr	Reverse Recovery Charge	di/dt=100A/µs, TJ=25℃		3		nC

Note :

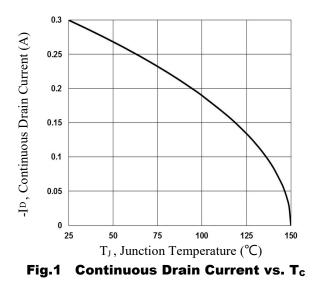
1. Repetitive Rating : Pulsed width limited by maximum junction temperature.

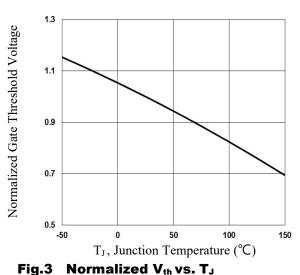
2. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.

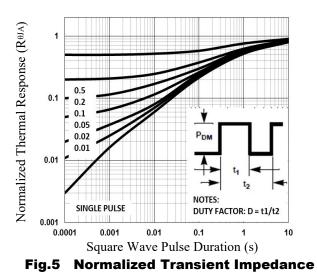
3. Essentially independent of operating temperature.

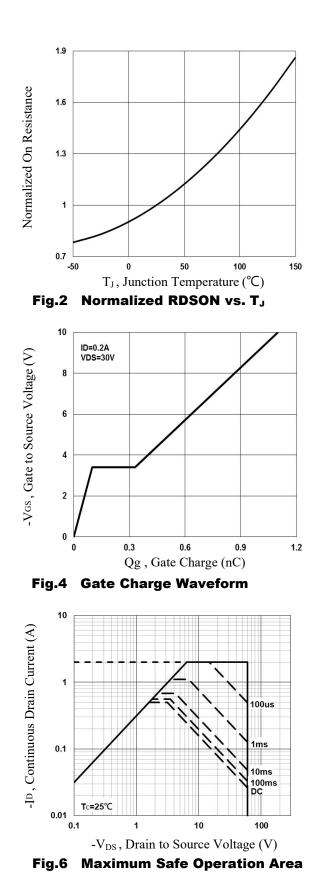


FDV302P HF Semiconductor Compiance



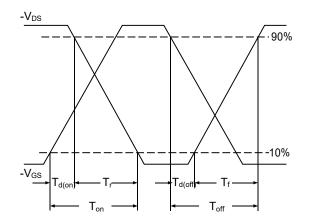












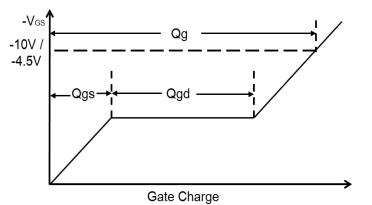


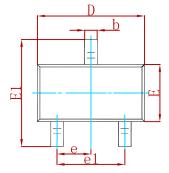
Fig.7 Switching Time Waveform

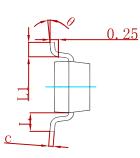
Fig.8 Gate Charge Waveform

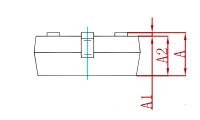




PACKAGE MECHANICAL DATA

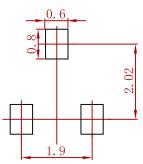






Sumbol	Symbol Dimensions In Millimeters		Dimension	s In Inches
Symbol	Min	Max	Min	Max
Α	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
С	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
е	0.950) TYP	0.037	7 TYP
e1	1.800	2.000	0.071	0.079
L	0.550 REF		0.022	2 REF
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

Suggested Pad Layout



Note:

Controlling dimension:in millimeters.
General tolerance:± 0.05mm.
The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
FDV302P	SOT-23	3000





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